

Dual N-Channel MOSFET

General Description

The WSD2012DN25 is the highest performance trench N-Channel MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The WSD2012DN25 meet the RoHS and Green Product requirement with full function reliability approved.

Product Summery

BV _{DSS}	R _{DSON}	Ι _D
20V	7.0mΩ	11A

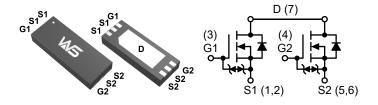
Applications

- Power management in portable and battery operated products
- DC-DC Power System
- ESD:2KV

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

DFN2X5-6S Pin Configuration



Absolute Maximum Ratings

Symbol	Symbol Parameter		Units
V _{DS}	Drain-Source Voltage	20	V
V _{GS}	Gate-Source Voltage	±12	V
I _D @T _A =25℃	Continuous Drain Current, V _{GS} @ 4.5V ¹	11	А
I _D @T _A =70℃	Continuous Drain Current, V _{GS} @ 4.5V ¹	9	А
I _{DM}	Pulsed Drain Current ²	95	A
P _D @T _A =25°C Total Power Dissipation ³		1.7	W
P _D @T _A =70°C Total Power Dissipation ³		1.0	W
T _{STG}	T _{STG} Storage Temperature Range		°C
TJ	T _J Operating Junction Temperature Range		°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-ambient ¹ (Steady State)		75	°C/W
R _{eja}	Thermal Resistance Junction-ambient ¹ (t<10S)		40	°C/W



Dual N-Channel MOSFET

Electrical Characteristics ÁÇ/JMÁG »Ô,Á\} /^••ÁJc@\; ã^Áp[c^åD

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	20			V	
$\triangle BV_{DSS} / \triangle T_J$	BVDSS Temperature Coefficient Reference to 25° C, I _D =1mA			0.022		V/℃	
D	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =5.5A	5.0	7.0	9.5	— mΩ	
R _{DS(ON)}		V _{GS} =2.5V , I _D =5.5A	6.8	9.0	13		
V _{GS(th)}	Gate Threshold Voltage		0.3	0.65	1.0	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} -V _{DS} , I _D -2500A		-2.32		mV/℃	
1	Drain Source Leekage Current	$V_{\text{DS}}\text{=}16\text{V}$, $V_{\text{GS}}\text{=}0\text{V}$, $T_{\text{J}}\text{=}25^\circ\!\mathrm{C}$			1		
I _{DSS}	Drain-Source Leakage Current	V_{DS} =16V , V_{GS} =0V , T_{J} =55 $^{\circ}\mathrm{C}$			5	μA	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = \pm 12V , V_{DS} =0V			±10	μA	
gfs	Forward Transconductance V _{DS} =5V , I _D =10A			65		S	
R _g	Gate Resistance V _{DS} =0V , V _{GS} =0V , f=1MHz			2500		Ω	
Qg	Total Gate Charge (4.5V)		10	12.5	15		
Q _{gs}	Gate-Source Charge			5.5		nC	
Q _{gd}	Gate-Drain Charge			6.5			
T _{d(on)}	Turn-On Delay Time			1.1			
Tr	Rise Time	V_{DD} =10V , V_{GS} =10V , R_G =1 Ω ,		2.6			
T _{d(off)}	Turn-Off Delay Time	I _D =1A ,RL=10Ω		7		μs	
T _f	Fall Time			7.4			
C _{iss}	Input Capacitance		1000	1256	1511		
Coss	Output Capacitance	V _{DS} =10V , V _{GS} =0V , f=1MHz	150	220	295	pF	
C _{rss}	Reverse Transfer Capacitance		100	168	238		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}				3	А
I _{SM}	Pulsed Source Current ^{2,4}	$V_G = V_D = 0V$, Force Current			45	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃		0.58	1.0	V
t _{rr}	Reverse Recovery Time			11		nS
Qrr	Reverse Recovery Charge	lF=10A,dl/dt=500A/μs , Tյ=25℃		15		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10sec.

2.The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%

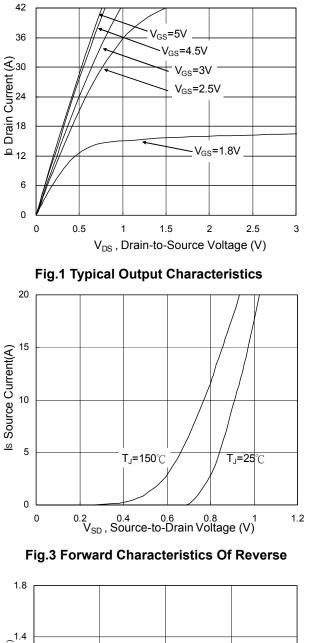
3. The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ junction temperature

4. The data is theoretically the same as I_{D} and I_{DM} , in real applications , should be limited by total power dissipation.



Dual N-Channel MOSFET

Typical Characteristics



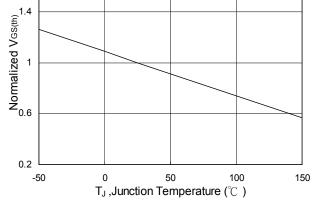


Fig.5 $V_{GS(th)}$ vs. T_J

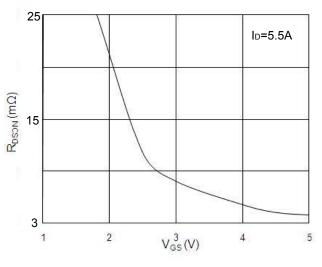


Fig.2 On-Resistance vs. Gate-Source

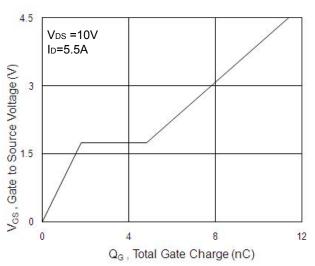
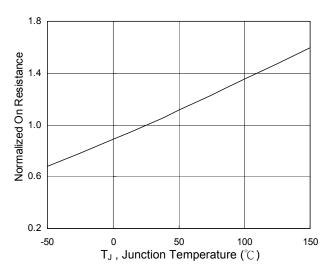


Fig.4 Gate-Charge Characteristics

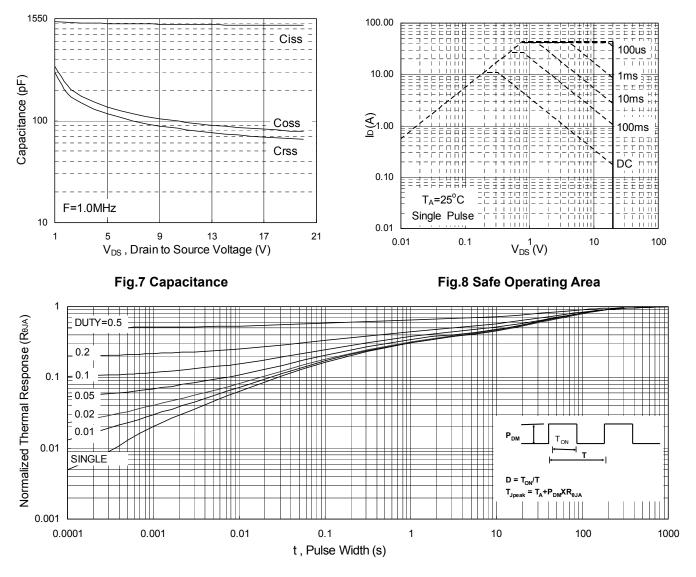






Dual N-Channel MOSFET

Typical Characteristics (Cont.)





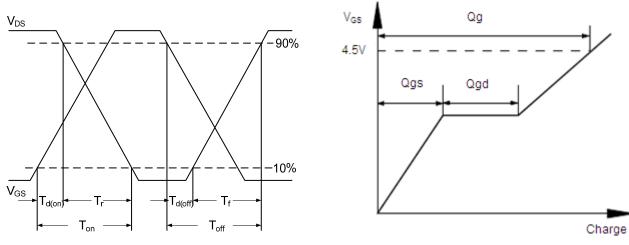


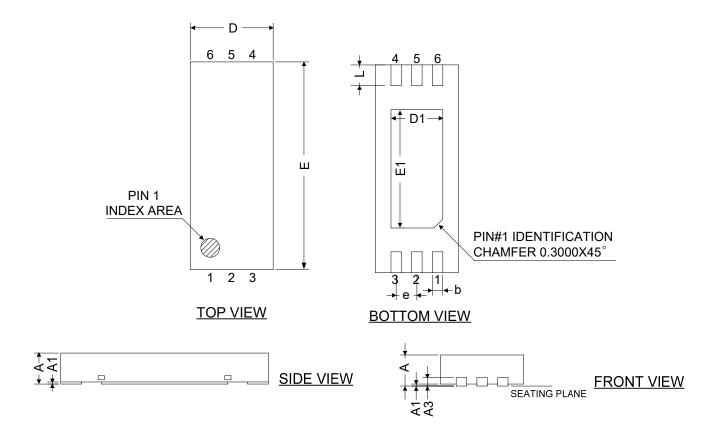
Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform



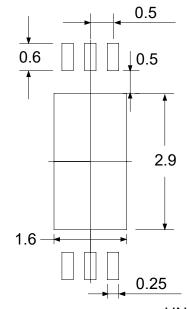
Dual N-Channel MOSFET

Packaging information



S	DFN2X5-6S				
S Y B O L	MILLIMETERS		INCHES		
O L	MIN.	MAX.	MIN.	MAX.	
А	0.70	1.00	0.028	0.039	
A1	0.00	0.05	0.000	0.002	
A3	0.10	0.203	0.004	0.008	
b	0.20	0.30	0.008	0.012	
D	1.90	2.10	0.075	0.083	
D1	1.20	1.55	0.047	0.061	
E	4.80	5.20	0.189	0.205	
E1	2.60	2.95	0.102	0.116	
е	0.50 BSC		0.02	0 BSC	
L	0.40	0.60	0.016	0.024	

RECOMMENDED LAND PATTERN



UNIT: mm



Attention

1, Any and all Winsok power products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your Winsok power representative nearest you before using any Winsok power products described or contained herein in such applications.

2, Winsok power assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all Winsok power products described or contained herein.

3, Specifications of any and all Winsok power products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.

4, Winsok power Semiconductor CO., LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.

5, In the event that any or all Winsok power products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.

6, No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of Winsok power Semiconductor CO., LTD.

7, Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. Winsok power believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.

8, Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the Winsok power product that you Intend to use.

9, this catalog provides information as of Sep.2014. Specifications and information herein are subject to change without notice.